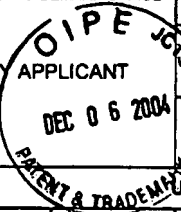


Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
258043US0PCTSERIAL NO.
10/506,994

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Edwin NUN, et al.FILING DATE
September 9, 2004

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>MND</i>	AA	US 2004/0154106	08-12-04	OLES ET AL.	—	—	
	AB	US 2003/0124301	07-03-03	OLES ET AL.	—	—	
	AC	US 2003/0108716	06-12-03	NUN ET AL.	—	—	
	AD	US 2003/0134086	07-17-03	NUN ET AL.	—	—	
	AE	US 2003/0147932	08-07-03	NUN ET AL.	—	—	
	AF	US 2003/0013795	01-16-03	NUN ET AL.	—	—	
	AG	US 2002/0148601	10-17-02	ROOS ET AL.	—	—	
	AH	US 6,811,856	11-02-04	NUN ET AL.	—	—	
	AI	US 2002/0150723	10-17-02	OLES ET AL.	—	—	
	AJ	US 2002/0150724	10-17-02	NUN ET AL.	—	—	
	AK	US 2002/0150725	10-17-02	NUN ET AL.	—	—	
<i>MND</i>	AL	US 2002/0164443	11-07-02	OLES ET AL.	—	—	
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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	AY	
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☐ Additional References sheet(s) attached

Examiner

MND

Date Considered

6-25-09

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Form PTO 1449
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ATTY DOCKET NO.

258043US0PCT

SERIAL NO.

New U.S. PCT Application
Based on PCT/EP03/01113

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Edwin NUN, et al.

10/506994

FILING DATE

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>MAE</i>	AA	2002/016433	02/07/02	KELLER, Harald et al.	—	—	
<i>MAE</i>	AB	4 963 388	10/16/90	BENOIT, Gordon L.	—	—	
	AC						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>MAE</i>	AO	199 44 169	03/29/01	DE		NO
<i>MAE</i>	AP	0 903 389	03/24/99	EP		NO
	AQ					
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	AS					
	AT					
	AU					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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☐ Additional References sheet(s) attached

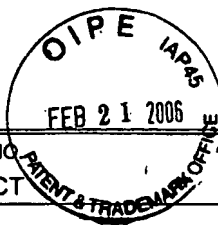
Examiner

Wm. W. W. W.

Date Considered

6-25-07

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 258043US0PCT		SERIAL NO. 10/506,994	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Edwin NUN, et al.			
				FILING DATE June 6, 2005		GROUP 1772	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>W. N.</i>	AA	US2002/0192385 A1	12/19/02	JENKNER, et al.	—	—	
<i>W. N.</i>	AB	US2003/0049396 A1	03/13/03	OLES, et al.	—	—	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>W. N. [Signature]</i>					Date Considered <i>6-25-07</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							